



PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Krutchinsky, et al.

Examiner: Paul M. Gurzo

Serial No.: 10/657,580

Group Art Unit: 2881

Filed: September 8, 2003

Docket: 1119-2 CON

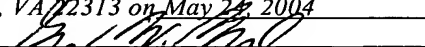
Confirmation No.: 9872

Dated: May 24, 2004

For: METHOD OF TRANSMITTING  
IONS FOR MASS SPECTROSCOPY

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

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**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Sir:

In order to fulfill the requirements of candor and good faith set forth in 37 C.F.R. § 1.56, Applicants submit a Supplemental Information Disclosure Statement in accordance with the provisions of 37 C.F.R. § 1.97 and § 1.98. This disclosure supplements the original Information Disclosure Statement filed on September 8, 2003.

**UNITED STATES PATENTS**

<b><u>PATENT NUMBER</u></b>	<b><u>ISSUE DATE</u></b>	<b><u>PATENTEE</u></b>
5,811,800	September 22, 1998	Franzen et al.
6,417,511	July 9, 2002	Russ, IV et al.

**NON-PATENT PUBLICATIONS**

1. B. Thomson, C. Jolliffe and R. Javahery, Proc. 44<sup>th</sup> ASMS Conf. on Mass Spectrometry and Allied Topics, p. 1155 (1996).

2. A.V. Tolmachev, et al., "A collisional focusing ion guide for coupling an atmospheric pressure ion source to a mass spectrometer", *Nuclear Instruments and Methods in Physics Research B* Vol. 124, pp. 112-119 (1997).

Applicants are in receipt of an Office Action dated February 23, 2004 and thus make the following certification as required under 37 C.F.R. § 1.97(c)(1).

**CERTIFICATION**

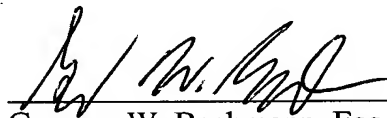
In accordance with 37 C.F.R. § 1.97(e)(2), the undersigned attorney for the Applicants hereby certifies that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign Patent Office and a counterpart foreign application, and to the knowledge of the person signing this certification after making a reasonable inquiry, no item of information contained in the Information Disclosure Statement was known to any individual designated in § 1.56(c) more than three months prior to the filing of the Information Disclosure Statement.

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If the Examiner has any questions or comments relating to the present application, he or she is respectfully invited to contact Applicants' attorney at the phone number set forth below.

Respectfully submitted,



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10/657,580INFORMATION DISCLOSURE  
STATEMENT BY APPLICANTAPPLICANT  
Krutchinsky, et al.CONFIRMATION NO.  
9872

(Use several sheets if necessary)

FILING DATE  
September 8, 003GROUP  
2881

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
		5,811,800	9/22/98	Franzen et al.			
		6,417,511	7/9/02	Russ, IV et al.			

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

			B. Thomson, C. Jolliffe and R. Javahery, Proc. 44 <sup>th</sup> ASMS Conf. on Mass Spectrometry and Allied Topics, p. 1155 (1996).
			A.V. Tolmachev, et al., "A collisional focusing ion guide for coupling an atmospheric pressure ion source to a mass spectrometer", <i>Nuclear Instruments and Methods in Physics Research B</i> Vol. 124, pp. 112-119 (1997).

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.